



RADIO TEST REPORT

Report No.:STS2009165W03

Issued for

XTR S.A.C.

Av. Camino Real 1225 Of 201-A San Isidro Lima, Peru

A B

Product Name:	Smart phone
Brand Name:	EKS
Model Name:	X6
Series Model:	N/A
FCC ID:	2AGAK-X6
Test Standard:	47 CFR Part 2, 27

APPROVAL

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Report No.: STS2009165W03

TEST RESULT CERTIFICATION

Applicant's Name	XTR S.A.C.
Address:	Av. Camino Real 1225 Of 201-A San Isidro Lima, Peru
Manufacturer's Name	ENCORP LIMITED
Address:	Room 411.4th floor, Yonghe high R&D building, NO.25 Langshan road, xili street, Nanshan district Shenzhen, China
Product Description	
Product Name:	Smart phone
Brand Name:	EKS
Model Name:	X6
Series Model:	N/A
Test Standards:	47 CFR Part 2, 27
Test Procedure:	KDB 971168 D01 v03r01, ANSI C63.26 2015
under test (EUT) is in compliance sample identified in the report. This report shall not be reproduce	been tested by STS, the test results show that the equipment with the FCC requirements. And it is applicable only to the tested ed except in full, without the written approval of STS, this document personal only, and shall be noted in the revision of the document.
Date of Test	
Date of receipt of test item	02 Sept. 2020
Date (s) of performance of tests.:	02 Sept. 2020 ~ 10 Sept. 2020
Date of Issue	10 Sept. 2020
Test Result:	Pass
Testing Engineer Technical Manag	(Chris Chen)
Authorized Signa	atory:

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(Vita Li)



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Revision History

Rev.	Issue Date	Report NO.	Effect Page	Contents
00	10 Sept. 2020	STS2009165W03	ALL	Initial Issue





1. TEST FACTORY & MEASUREMENT UNCERTAINTY

1.1 TEST FACTORY

SHENZHEN STS TEST SERVICES CO., LTD

Add.: A 1/F, Building B, Zhuoke Science Park, No.190 Chongqing Road, HepingShequ,

Fuyong Sub-District, Bao'an District, Shenzhen, Guang Dong, China

FCC test Firm Registration Number: 625569 IC test Firm Registration Number: 12108A

A2LA Certificate No.: 4338.01

1.2 MEASUREMENT UNCERTAINTY

The reported uncertainty of measurement $y \pm U$, where expended uncertainty U is based on a standard uncertainty multiplied by a coverage factor of k=2, providing a level of confidence of approximately 95 %.

No.	Item	Uncertainty
1	RF output power, conducted	±0.68dB
2	Unwanted Emissions, conducted	±2.988dB
3	All emissions, radiated 30-1GHz	±5.6dB
4	All emissions, radiated 1G-6GHz	±5.5dB
5	All emissions, radiated>6G	±5.8dB
6	Conducted Emission (9KHz-150KHz)	±3.37dB
7	Conducted Emission (150KHz-30MHz)	±3.83dB



2. GENERAL INFORMATION

2.1 TECHNICAL SPECIFICATIONS AND REGULATIONS

2.1.1 PRODUCT DESCRIPTION

A major technical description of EUT is described as following:

Product Name	Smart phone				
Trade Name	EKS				
Model Name	X6				
Series Model	N/A				
Model Difference	N/A				
Frequency Bands	U.S. Bands: LTE FDD Band 4 LTE FDD Band 28 (Band28 is not within the US bands)				
SIM Card	SIM 1 and SIM 2 is a chipset unit and tested as single chipset, SIM 1 is used to tested.				
Antenna	PIFA				
Antenna gain	LTE Band 4: 0.7dBi				
Battery parameter	Rated Voltage: 3.8V Charge Limit: 4.35V Capacity: 3000mAh				
Adapter	Input: AC 100-240V, 150mA, 50/60Hz Output: DC 5V, 1A				
Extreme Vol. Limits	4.35V to 3.5V (Nominal 3.8V)				
Extreme Temp. Tolerance	-30°C to +50°C				
Hardware version number	J517C_63_32EMB_03EFV1.1				
Software version number	XTR_X6_PE_V01_20201107				





2.1.2 PRODUCT SPECIFICATION SUBJECTIVE TO THIS STANDARD

Pro	Product Specification Subjective To This Standard						
Tx Frequency	LTE Band 4:1710~1755MHz LTE Band 28:703~824MHz						
Rx Frequency	LTE Band 4:2110~2155MHz LTE Band 28:859~869MHz						
Bandwidth	LTE Band 4: 1.4MHz / 3MHz / 5MHz / 10MHz / 15MHz/20MHz						
Maximum Output Power	LTE Band 4: 22.89 dBm						
Type of Modulation	QPSK /16QAM						

RF Function	Band	UE Category UL	Modulati on	Power Class	Ant Gain(dBi)	Ant Type	SIM Card
LTE	FDD:4	4	QPSK /16QAM	3	LTE B4:0.7	PIFA	2 SIM 1 is used to tested.

2.1.3 EMISSION DESIGNATOR

LTE Band 4	Emission Designator	Emission Designator
BW(MHz)	(99% BW)QPSK	(99% BW)16QAM
1.4	1M10G7D	1M11W7D
3	2M69G7D	2M69W7D
5	4M53G7D	4M55W7D
10	8M95G7D	8M94W7D
15	13M5G7D	13M5W7D
20	18M0G7D	18M0W7D



2.1.4 TEST CONFIGURATION OF EQUIPMENT UNDER TEST

Antenna port conducted and radiated test items listed below are performed according to KDB 971168 D01 v03r01 and ANSI C63.26 2015 Power Meas. License Digital Systems with maximum output power. Radiated measurements are performed by rotating the EUT in three different orthogonal test planes tofind the maximum emission.

- 1. The mark 'v'means that this configuration is chosen for testing
- 2. The mark '-'means that this bandwidth is not supported.
- 3. The device is investigated from 30MHz to 10 times of fundamental signal for radiated.

ITEMS	Band	Е	Band	dwic	lth (I	ИНz	<u>z</u>)	Modul	lation		RB#		CI	Test nann	
		1.4	3	5	10	15	20	QPSK	16QAM	1	Half	Full	L	М	Н
Max. Output Power	4	v	>	>	>	>	٧	٧	٧	٧	V	٧	٧	٧	V
Peak&Avera Ratio	4						V	٧	V	>		٧	٧	٧	٧
26dB&99% Bandwidth	4	V	V	٧	٧	٧	٧	٧	V			٧	٧	٧	v
Conducted Band Edge	4	٧	٧	٧	٧	٧	٧	٧	V	٧		V	٧	٧	٧
Conducted Spurious Emission	4	V	٧	٧	٧	٧	V	V	V	V			٧	٧	٧
Frequency Stability	4				٧			V				V		٧	
E.R.P.& E.I.R.P.	4	v	>	>	٧	>	V	٧	V	V			٧	٧	٧
Radiated Spurious Emission	4	V	٧	٧	٧	٧	V	٧		٧			V	V	V



2.1.5 RELATED SUBMITTAL(S) / GRANT (S)

This submittal(s) (test report) is intended for filing to comply with the 47 CFR Part 2, 27.

2.1.6 SPECIAL ACCESSORIES

The battery and the charger, earphone supplied by the applicant were used as accessories and being tested with eut intended for fcc grant together.

2.1.7 EUT CONFIGURATION

The EUT configuration for testing is installed on RF field strength measurement to meet the Commission's requirement and operating in a manner which intends to maximize its emission characteristics in a continuous normal application.

2.1.8 EUT EXERCISE

The Transmitter was operated in the maximum output power mode through Communication Tester. The TX frequency was fixed which was for the purpose of the measurements.



2.1.9 CONFIGURATION OF EUT SYSTEM

The EUT configuration for testing is installed on RF field strength measurement to meet the Commission's requirement and operating in a manner which intends to maximize its emission characteristics in a continuous normal application.

E-1 EUT

Table 2-1 Equipment Used in EUT System

Item	Equipment	Model No.	Length	Note
N/A	N/A	N/A	N/A	N/A

Note:

(1) For detachable type I/O cable should be specified the length in cm in [®] Length ^a column.



2.1.10 MEASUREMENT INSTRUMENTS

The radiated emission testing was performed according to the procedures of ANSI C63.26 2015 and FCC CFR 47 rules of 2.1046, 2.1047, 2.1049, 2.1051, 2.1053, 2.1055, 2.1057.

Radiation Test equipment

Radiation Test equipme	IIL			ı			
Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until		
Test Receiver	R&S	ESCI	101427	2019.10.09	2020.10.08		
Signal Analyzer	Agilent	N9020A	MY51110105	2020.03.05	2021.03.04		
Wireless Communications Test Set	R&S	CMW 500 133884		2020.03.05	2021.03.04		
Bilog Antenna	TESEQ	CBL6111D	34678	2017.11.02	2020.11.01		
Horn Antenna	SCHWARZBECK	BBHA 9120D(1201)	9120D-1343	2018.10.19	2021.10.18		
SHF-EHF Horn Antenna (18G-40GHz)	A-INFO	LB-180400-KF	J211020657	2018.03.11	2021.03.10		
Pre-Amplifier (0.1M-3GHz)	EM	EM330	060665	2019.10.09	2020.10.08		
Pre-Amplifier (1G-18GHz)	SKET	LNPA-01018G-45	SK2018080901	2019.10.12	2020.10.11		
Pre-Amplifier (18G-40GHz)	SKET	LNPA-1840-50	SK2018101801	2019.10.12	2020.10.11		
Turn table	EM	SC100_1	60531	N/A	N/A		
Antenna mast	EM	SC100	N/A	N/A	N/A		
Temperature & Humidity	HH660	Mieo	N/A	2019.10.17	2020.10.16		
Test SW	BULUN	BL410-E/18.905					

RF Connected Test

Tri Connected lest					
Kind of Equipment	Manufacturer	Type No.	Serial No.	Last	Calibrated
1.1		71.		calibration	until
Universal Radio					
communication tester	R&S	CMU200	119907	2020.10.11	2021.10.10
Wireless Communications Test Set	R&S	CMW 500	133884	2020.03.05	2021.03.04
Signal Analyzer	Agilent	N9020A	MY49100060	2019.10.09	2020.10.08
Temperature & Humidity	HH660	Mieo	N/A	2019.10.17	2020.10.16
Test SW	FARAD		LZ-RF /LzRf-	3A3	



2.1.11 MEASUREMENT RESULTS EXPLANATION EXAMPLE

For all conducted test items:

The offset level is set in the spectrum analyzer to compensate the RF cable loss and attenuator factorbetween EUT conducted output port and spectrum analyzer. With the offset compensation, the spectrum analyzer reading level is exactly the EUT RF output level.

The spectrum analyzer offset is derived from RF cable loss and attenuator factor.

Offset = RF Cable Loss + Attenuator Factor.





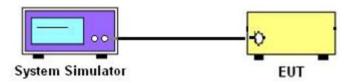


- 3. CONDUCTED OUTPUT POWER
- 3.1 DESCRIPTION OF THE CONDUCTED OUTPUT POWER MEASUREMENT

3.1.1 MEASUREMENT METHOD

A system simulator was used to establish communication with the eut. Its parameters were set to force the eut transmitting at maximum output power. The measured power in the radio frequency on the transmitter output terminals shall be reported. Configuration follows KDB 971168 D01 v03r01.

3.1.2 TEST SETUP



3.1.3 TEST PROCEDURES

- 1. The transmitter output port was connected to system simulator.
- 2. Set EUT at maximum power through the system simulator.
- 3. Select lowest/middle/highest channels for each band and different modulation.
- 4. Measure and record the power level from the system simulator.



3.1.4 TEST RESULTS

	LTE	Band 4 Maxim	um Average Po	ower [dBm]		
BW [MHz]	RB Size	RB Offset	Mod	Lowest	Middle	Highest
1.4	1	0		22.36	22.29	22.4
1.4	1	2		22.13	22	22.17
1.4	1	5		21.9	21.71	21.88
1.4	3	0	QPSK	21.62	21.42	21.6
1.4	3	1		21.37	21.17	21.31
1.4	3	2		21.09	20.94	21.06
1.4	6	0		20.89	20.7	20.76
1.4	1	0		22.11	22.08	22.16
1.4	1	2		21.87	21.82	21.91
1.4	1	5		21.59	21.6	21.66
1.4	3	0	16-QAM	21.35	21.36	21.44
1.4	3	1		21.06	21.14	21.2
1.4	3	2		20.84	20.84	20.92
1.4	6	0		20.6	20.61	20.65
3	1	0		22.24	22.43	22.14
3	1	7		21.98	22.17	21.87
3	1	14		21.71	21.92	21.59
3	8	0	QPSK	21.44	21.64	21.38
3	8	4		21.18	21.34	21.17
3	8	7		20.94	21.13	20.96
3	15	0		20.73	20.87	20.7
3	1	0		22.04	22.22	21.93
3	1	7	16-QAM	21.79	21.99	21.69
3	1	14		21.5	21.75	21.46
3	8	0		21.23	21.47	21.19
3	8	4		20.95	21.26	20.91
3	8	7		20.65	21.03	20.7
3	15	0		20.41	20.76	20.48



	LTE	Band 4 Maxim	um Average Po	ower [dBm]		
BW [MHz]	RB Size	RB Offset	Mod	Lowest	Middle	Highest
5	1	0		22.45	22.23	22.46
5	1	12		22.22	22.01	22.25
5	1	24		21.99	21.77	22.04
5	12	0	QPSK	21.7	21.54	21.83
5	12	6		21.44	21.28	21.56
5	12	11		21.23	21.05	21.32
5	25	0		20.96	20.82	21.1
5	1	0		22.23	22	22.19
5	1	12		21.98	21.75	21.93
5	1	24		21.76	21.54	21.72
5	12	0	16-QAM	21.48	21.26	21.5
5	12	6		21.24	21.06	21.27
5	12	11		20.96	20.81	21.07
5	25	0		20.72	20.51	20.87
10	1	0		22.48	22.65	22.36
10	1	24		22.19	22.36	22.06
10	1	49		21.92	22.07	21.84
10	25	0	QPSK	21.62	21.79	21.54
10	25	12		21.38	21.58	21.26
10	25	24		21.13	21.33	20.99
10	50	0		20.89	21.04	20.71
10	1	0		22.21	22.39	22.1
10	1	24		21.93	22.14	21.89
10	1	49		21.69	21.87	21.63
10	25	0	16-QAM	21.49	21.58	21.42
10	25	12		21.28	21.32	21.14
10	25 24			21.07	21.04	20.87
10		0		20.79	20.78	20.66



	LTE	Band 4 Maxim	um Average Po	ower [dBm]		
BW [MHz]	RB Size	RB Offset	Mod	Lowest	Middle	Highest
15	1	0		22.55	22.31	22.23
15	1	37		22.34	22.02	22.01
15	1	74		22.1	21.73	21.78
15	36	0	QPSK	21.87	21.51	21.55
15	36	18		21.62	21.31	21.28
15	36	39		21.39	21.02	21
15	75	0		21.17	20.74	20.77
15	1	0		22.29	22.01	21.96
15	1	38		22.05	21.8	21.66
15	1	75		21.77	21.52	21.39
15	36	0	16-QAM	21.55	21.29	21.09
15	36	18		21.25	21.05	20.87
15	36	39		20.98	20.84	20.59
15	75	0		20.72	20.55	20.29
20	1	0		22.68	22.89	22.74
20	1	49		22.45	22.67	22.49
20	1	99		22.21	22.45	22.28
20	50	0	QPSK	21.92	22.21	22.01
20	50	24		21.63	21.99	21.71
20	50	49		21.34	21.73	21.41
20	100	0		21.08	21.43	21.15
20	1	0		22.39	22.63	22.44
20	1	49		22.12	22.4	22.21
20	1	99		21.83	22.14	22
20	50	0	16-QAM	21.6	21.91	21.72
20	50	24		21.33	21.63	21.44
20	50	49		21.05	21.37	21.2
20	100	0		20.8	21.08	20.94



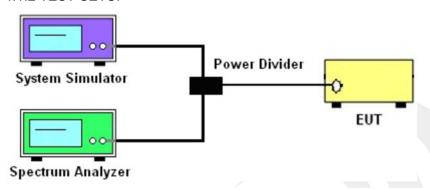
4. PEAK-TO-AVERAGE RATIO

4.1 DESCRIPTION OF THE CONDUCTED OUTPUT POWER MEASUREMENT

4.1.1 MEASUREMENT METHOD

Use one of the procedures presented in 4.1.3 to measure the total peak power and record as PPk. Use one of the applicable procedures presented 4.1.3 to measure the total average power and record as PAvg. Both the peak and average power levels must be expressed in the same logarithmic units (e.g., dBm). Determine the PAPR from: PAPR (dB) = PPk (dBm) - PAvg (dBm).

4.1.2 TEST SETUP



4.1.3 TEST PROCEDURES

- 1. The testing follows FCC KDB 971168 D01 v03r01 Section 5.7 and ANSI C63.26 2015 Section 5.2.6.
- 2. The EUT was connected to spectrum and system simulator via a power divider
- 3. Select lowest, middle, and highest channels for each band and different modulation.
- 4. Set the test probe and measure the peak and average power of the spectrum analyzer
- 5. Record the deviation as Peak to Average Ratio.

		LTE									
LTE BW	1.4M	3M	5M	10M	15M	20M					
Span	3MHz	6MHz	10MHz	20MHz	30MHz	40MHz					
RBW	30kHz	30kHz	100kHz	100kHz	300kHz	300kHz					
VBW	100kHz	100kHz	300kHz	300kHz	1000kHz	1000kHz					
Detector	PK/AVG	PK/AVG	PK/AVG	PK/AVG	PK/AVG	PK/AVG					
Trace	Max	Max	Max	Max	Max	Max					
Sweep Count	Auto	Auto	Auto	Auto	Auto	Auto					



4.1.4 TEST RESULTS

	ITE Pand 4 DAD [dDm]										
LTE Band 4 PAR [dBm]											
D\\\/ [\\/∐→1	BW [MHz] RB Size Modulation Lowest Middle Highest										
DVV [IVIIIZ]	RD SIZE	Modulation	P-A	P-A	P-A						
20	1	ODCK	5.4	5.33	4.37						
20	100	QPSK	5.57	5.59	5.71						
20	1	16-QAM	5.61	6.13	5.62						
20	100	10-QAM	6.31	6.26	6.32						
	Limit			≤13dB							

Note: Test chart See Appendix D







5. RADIATED POWER AND EFFECTIVE ISOTROPIC RADIATED POWER

5.1 DESCRIPTION OF THE ERP/EIRP MEASUREMENT

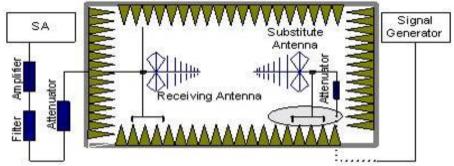
5.1.1 MEASUREMENT METHOD

Effective radiated power output measurements by substitution method according to ANSI C63.26 2015, and the spectrum analyzer configuration follows KDB 971168 D01 Power Meas. License Digital Systems. Mobile and portable (hand-held) stations operating are limited to average ERP, Equivalent isotropic radiated power output measurements by substitution method according to ANSI C63.26 2015, and the spectrum analyzer configuration follows KDB 971168 D01 Power Meas, Mobile and portable (hand-held) stations operating are limited to average EIRP.

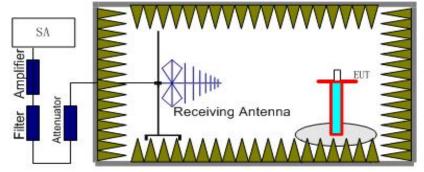
5.1.2 TEST SETUP

The procedure of radiated spurious emissions is as follows:

a) Pre-calibration With pre-calibration method, the Radiated Spurious Emissions(RSE) is calculated as, RSE=Rx (dBuV) +CL (dB) +SA (dB) +Gain (dBi) -107 (dBuV to dBm) The SA is calibrated using following setup.



b) EUT was placed on a 1.5m non-conductive stand at a 3 m test distance from the receive antenna. A receiving antenna was placed on the antenna mast 3 m from the test item for emission measurements. The height of receiving antenna is 0.8m. The test setup refers to figure below. Detected emissions were maximized at each frequency by rotating the test item and adjusting the receiving antenna polarization. The radiated emission measurements of all non-harmonic and harmonics of the transmit frequency through the 10th harmonic measured with peak detector and 1MHz bandwidth.



Radiated emissions measurements were made only at the upper, middle, and lower carrier frequencies It was decided that measurements at these three carrier frequencies would be sufficient to demonstrate compliance with emissions limits because it was seen that all the significant spurs occur well outside the band and no radiation was seen from a carrier in one block of any band into any of the other blocks.

The substitution method is used. Substitution values at each frequency are measured before and saved to the test software. A "reference path loss" is established and the ARpl is the attenuation of "reference path loss", and including the gain of receive antenna, the gain of the preamplifier, the cable loss and the air loss. The measurement results are obtained as described below: Power=PMea+ARpl

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5.1.3 TEST PROCEDURES

- 1. The testing follows FCC KDB 971168 D01v03r01 Section 5.6 and ANSI C63.26 2015 Section 5.2.
- 2. The EUT was placed on a non-conductive rotating platform 1.5 meters high in a semi-anechoic chamber. The radiated emission at the fundamental frequency was measured at 3 m with a test antenna and a spectrum analyzer with Peak detector.
- 3. During the measurement, the system simulator parameters were set to force the EUTtransmitting at maximum output power. The maximum emission was recorded from analyzer power level (LVL) from the 360 degrees rotation of the turntable and the test antenna raised and lowered over a range from 1 to 4 m in both horizontally and vertically polarized orientations.
- 4. Effective Isotropic Radiated Power (EIRP) was measured by substitution method according to ANSI C63.26 2015. The EUT was replaced by dipole antenna (substitution antenna) at same location and then a known power from S.G. was applied into the dipole antenna through a Tx cable, and then recorded the maximum Analyzer reading through raised and lowered the test antenna. EIRP=S.G Level+ Gain-Cable loss; ERP=S.G Level+ Gain-Cable loss-2.15.
- 5. RB Set greater than bandwidth, VB Set spectrum analyzer Maximum support.



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5.1.4 TEST RESULTS

Note: Test is divided into three directions, X/Y/Z. X pattern for the worst.

			Radi	ated Power	(EIRP) fo	or LTE Bar	nd 4 / 1.4M				
		RB			Result						
Modulation	Г	ND.	Channal	S	0 - 1-1 -	0 - :	DM	Polarization	Conducion		
Modulation	Size	Offset	Channel	G.Level loss		Gain (dBi)	PMeas E.I.R.P(dBm)	Of Max. EIRP	Conclusion		
	1	0	Lowest	12.02	2.35	10.13	19.80	Horizontal	Pass		
	1	0	Middle	11.83	2.36	10.16	19.63	Horizontal	Pass		
ODOK	1	0	Highest	11.86	2.37	10.22	19.71	Horizontal	Pass		
QPSK	1	0	Lowest	13.32	2.35	10.13	21.10	Vertical	Pass		
	1	0	Middle	13.19	2.36	10.16	20.99	Vertical	Pass		
	1	0	Highest	13.32	2.37	10.22	21.17	Vertical	Pass		
	1	0	Lowest	11.51	2.35	10.13	19.29	Horizontal	Pass		
	1	0	Middle	11.56	2.36	10.16	19.36	Horizontal	Pass		
160014	1	0	Highest	11.57	2.37	10.22	19.42	Horizontal	Pass		
16QAM	1	0	Lowest	12.96	2.35	10.13	20.74	Vertical	Pass		
	1	0	Middle	13.01	2.36	10.16	20.81	Vertical	Pass		
	1	0	Highest	13.01	2.37	10.22	20.86	Vertical	Pass		
Limit		EIRP<1W=30dBm									

			Rad	iated Powe	r (FIRP) f	or LTE Ba	and 4 / 3M				
			Itau	iated i owe	i (Elixi) i	7.1	esult				
Madulation	ŀ	RB	Channal	S	0-1-1-	Coin	DMass	Polarization	Canalysian		
Modulation	Size	Offset	Channel	G.Level loss		Gain (dBi)	PMeas E.I.R.P(dBm)	Of Max. EIRP	Conclusion		
	1	0	Lowest	11.72	2.35	10.13	19.50	Horizontal	Pass		
	1	0	Middle	11.79	2.36	10.16	19.59	Horizontal	Pass		
QPSK	1	0	Highest	11.51	2.37	10.22	19.36	Horizontal	Pass		
QPSK	1	0	Lowest	13.12	2.35	10.13	20.90	Vertical	Pass		
	1	0	Middle	13.28	2.36	10.16	21.08	Vertical	Pass		
	1	0	Highest	12.99	2.37	10.22	20.84	Vertical	Pass		
	1	0	Lowest	11.5	2.35	10.13	19.28	Horizontal	Pass		
	1	0	Middle	11.71	2.36	10.16	19.51	Horizontal	Pass		
16QAM	1	0	Highest	11.34	2.37	10.22	19.19	Horizontal	Pass		
IOQAW	1	0	Lowest	12.92	2.35	10.13	20.70	Vertical	Pass		
	1	0	Middle	13.17	2.36	10.16	20.97	Vertical	Pass		
	1	0	Highest	12.79	2.37	10.22	20.64	Vertical	Pass		
Limit		EIRP<1W=30dBm									





			Radi	ated Power	r (EIRP) f	or LTE Ba	and 4 / 5M				
		חר				Re	esult				
Madulation	r	RB	01	S	Cabla	0-:	DMass	Polarization	Canalysian		
Modulation	Size	Offset	Channel	G.Level (dBm)	Cable loss	Gain (dBi)	PMeas E.I.R.P(dBm)	Of Max. EIRP	Conclusion		
	1	0	Lowest	12.15	2.35	10.13	19.93	Horizontal	Pass		
	1	0	Middle	11.59	2.36	10.16	19.39	Horizontal	Pass		
QPSK	1	0	Highest	12.02	2.37	10.22	19.87	Horizontal	Pass		
QPSK	1	0	Lowest	13.47	2.35	10.13	21.25	Vertical	Pass		
	1	0	Middle	13.04	2.36	10.16	20.84	Vertical	Pass		
	1	0	Highest	13.41	2.37	10.22	21.26	Vertical	Pass		
	1	0	Lowest	11.86	2.35	10.13	19.64	Horizontal	Pass		
	1	0	Middle	11.6	2.36	10.16	19.40	Horizontal	Pass		
16QAM	1	0	Highest	11.6	2.37	10.22	19.45	Horizontal	Pass		
IOQAW	1	0	Lowest	13.22	2.35	10.13	21.00	Vertical	Pass		
	1	0	Middle	12.91	2.36	10.16	20.71	Vertical	Pass		
	1	0	Highest	12.98	2.37	10.22	20.83	Vertical	Pass		
Limit		EIRP<1W=30dBm									

			Radia	ated Power	(EIRP) fo	or LTE Ba	nd 4 / 10M				
		סס				Re	esult				
Modulation	ľ	RB	Channel	S Cable	Cable	Gain	PMeas	Polarization	Conclusion		
Modulation	Size	Offset	Gridinie	G.Level (dBm)	loss	(dBi)	E.I.R.P(dBm)	Of Max. EIRP	Conclusion		
	1	0	Lowest	12.12	2.35	10.13	19.90	Horizontal	Pass		
	1	0	Middle	12.12	2.36	10.16	19.92	Horizontal	Pass		
QPSK	1	0	Highest	11.78	2.37	10.22	19.63	Horizontal	Pass		
QFSK	1	0	Lowest	13.49	2.35	10.13	21.27	Vertical	Pass		
	1	0	Middle	13.49	2.36	10.16	21.29	Vertical	Pass		
	1	0	Highest	13.22	2.37	10.22	21.07	Vertical	Pass		
	1	0	Lowest	11.8	2.35	10.13	19.58	Horizontal	Pass		
	1	0	Middle	11.83	2.36	10.16	19.63	Horizontal	Pass		
16QAM	1	0	Highest	11.46	2.37	10.22	19.31	Horizontal	Pass		
IOQAM	1	0	Lowest	13.15	2.35	10.13	20.93	Vertical	Pass		
	1	0	Middle	13.28	2.36	10.16	21.08	Vertical	Pass		
	1	0	Highest	12.87	2.37	10.22	20.72	Vertical	Pass		
Limit		EIRP<1W=30dBm									





			Rad	iated Power	(EIRP) fo	or LTE Bai	nd 4 / 15M				
		חר			Result						
NA advolation	RB		Ob a made of	S	0-1-1-	0 - :	DM	Polarization	Complyation		
Modulation	Size	Offset	Channel	G.Level loss (dBm)		Gain (dBi)	PMeas E.I.R.P(dBm)	Of Max. EIRP	Conclusion		
	1	0	Lowest	11.97	2.35	10.13	19.75	Horizontal	Pass		
	1	0	Middle	11.8	2.36	10.16	19.60	Horizontal	Pass		
ODCK	1	0	Highest	11.74	2.37	10.22	19.59	Horizontal	Pass		
QPSK	1	0	Lowest	13.4	2.35	10.13	21.18	Vertical	Pass		
	1	0	Middle	13.24	2.36	10.16	21.04	Vertical	Pass		
	1	0	Highest	13.07	2.37	10.22	20.92	Vertical	Pass		
	1	0	Lowest	11.87	2.35	10.13	19.65	Horizontal	Pass		
	1	0	Middle	11.51	2.36	10.16	19.31	Horizontal	Pass		
160014	1	0	Highest	11.42	2.37	10.22	19.27	Horizontal	Pass		
16QAM	1	0	Lowest	13.18	2.35	10.13	20.96	Vertical	Pass		
	1	0	Middle	12.85	2.36	10.16	20.65	Vertical	Pass		
	1	0	Highest	12.84	2.37	10.22	20.69	Vertical	Pass		
Limit		EIRP<1W=30dBm									

			Rad	iated Power	(EIRP) fo	or LTE Bar	nd 4 / 20M				
	Г	RB	/		Result						
Modulation	Г	ND N	Channel	S	Cable	Gain	PMeas	Polarization	Conclusion		
Modulation	Size	Offset	Chamile	G.Level (dBm)	loss	(dBi)	E.I.R.P(dBm)	Of Max. EIRP	Conclusion		
	1	0	Lowest	12.11	2.35	10.13	19.89	Horizontal	Pass		
	1	0	Middle	12.45	2.36	10.16	20.25	Horizontal	Pass		
QPSK	1	0	Highest	12.24	2.37	10.22	20.09	Horizontal	Pass		
QFSK	1	0	Lowest	13.53	2.35	10.13	21.31	Vertical	Pass		
	1	0	Middle	13.78	2.36	10.16	21.58	Vertical	Pass		
	1	0	Highest	13.62	2.37	10.22	21.47	Vertical	Pass		
	1	0	Lowest	12.05	2.35	10.13	19.83	Horizontal	Pass		
	1	0	Middle	12.1	2.36	10.16	19.90	Horizontal	Pass		
16QAM	1	0	Highest	11.72	2.37	10.22	19.57	Horizontal	Pass		
IOQAM	1	0	Lowest	13.35	2.35	10.13	21.13	Vertical	Pass		
	1	0	Middle	13.51	2.36	10.16	21.31	Vertical	Pass		
	1	0	Highest	13.2	2.37	10.22	21.05	Vertical	Pass		
Limit		EIRP<1W=30dBm									



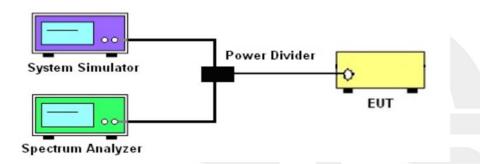
6. OCCUPIED BANDWIDTH

6.1 DESCRIPTION OF OCCUPIED BANDWIDTH MEASUREMENT

6.1.1 MEASUREMENT METHOD

- 1. The occupied bandwidth is the width of a frequency band such that, below the lower and above the upper frequency limits, the mean powers emitted are each equal to a specified percentage 0.5% of the total mean transmitted power.
- 2. The 26 db emission bandwidth is defined as the frequency range between two points, one above and one below the carrier frequency, at which the spectral density of the emission is attenuated 26 db below the maximum in-band spectral density of the modulated signal. spectral density (power per unit bandwidth) is to be measured with a detector of resolution bandwidth equal to approximately 1.0% of the emission bandwidth.

6.1.2 TEST SETUP



6.1.3 TEST PROCEDURES

- 1. The testing follows FCC KDB 971168 D01 v03r01 Section 4.2 and 4.3.
- 2. The EUT was connected to spectrum and system simulator via a power divider.
- 3. Select lowest, middle, and highest channels for each band and different modulation.
- 4. Set the test probe and measure the Occupied Bandwidth of the spectrum analyzer.
- 5. Measure and record the Occupied Bandwidth from the Spectrum Analyzer.

	LTE							
LTE BW	1.4M	3M	5M	10M	15M	20M		
Span	3MHz	6MHz	10MHz	20MHz	30MHz	40MHz		
RBW	30kHz	30kHz	100kHz	100kHz	300kHz	300kHz		
VBW	100kHz	100kHz	300kHz	300kHz	1000kHz	1000kHz		
Detector	PK	PK	PK	PK	PK	PK		
Trace	Max	Max	Max	Max	Max	Max		
Sweep Count	Auto	Auto	Auto	Auto	Auto	Auto		



6.1.4 MEASUREMENT RESULT

		LT	E Band 4 Ba	ndwidth [M	Hz]			
BW [MHz]	Mode	Lov	west	Mid	ddle	Highest		
		99% BW	26dB BW	99% BW	26dB BW	99% BW	26dB BW	
1.4	QPSK	1.097	1.296	1.1031	1.301	1.0962	1.27	
1.4	16-QAM	1.0923	1.284	1.1014	1.305	1.1041	1.268	
3	QPSK	2.6917	3.003	2.6817	2.98	2.6885	2.992	
3	16-QAM	2.6863	2.99	2.6862	3.006	2.6879	3.018	
5	QPSK	4.5198	5.403	4.5348	5.272	4.518	5.237	
5	16-QAM	4.5465	5.428	4.5525	5.415	4.5214	5.299	
10	QPSK	8.9427	9.888	8.9535	9.731	8.9389	9.754	
10	16-QAM	8.9402	9.819	8.9422	10	8.942	9.769	
15	QPSK	13.456	15.23	13.5	15.33	13.464	15.19	
15	16-QAM	13.519	15.23	13.505	14.85	13.497	14.97	
20	QPSK	17.939	19.96	17.984	19.87	17.959	19.71	
20	16-QAM	17.992	19.78	17.926	19.63	17.956	19.8	

Note: Test chart See Appendix A

Report No.: STS2009165W03



7. CONDUCTED BAND EDGE

7.1 DESCRIPTION OF CONDUCTED BAND EDGE MEASUREMENT

7.1.1 MEASUREMENT METHOD

1. §22.917(a)

For operations in the 824 – 849 MHz band, the FCC limit is 43 + 10log10(P[Watts]) dB below the transmitter power P(Watts) in a 100kHz bandwidth. However, in the 1MHz bands immediately outside and adjacent to the licensee's frequency block, a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed.

2. §24.238 (a)

For operations in the 1850-1910 and 1930-1990 MHz band, the FCC limit is 43 + 10log10(P[Watts]) dB below the transmitter power P(Watts) in a 1MHz bandwidth. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed

3. §27.53 (h)

For operations in the 1710 – 1755 MHz band, the FCC limit is 43 + 10log10(P[Watts]) dB below the transmitter power P(Watts) in a 1 MHz bandwidth. However, in the 1MHz bands immediately outside and adjacent to the licensee's frequency block, a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed.

4. §27.53(m)(4)

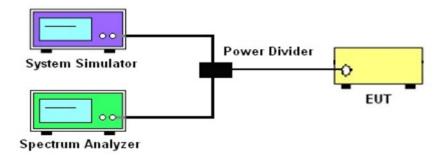
For operations in the 2500 MHz ~ 2570 MHz band this section, the attenuation factor shall be not less than 40 + 10 log (P) dB on all frequencies between the channel edge and 5 megahertz from the channel edge, 43 + 10 log (P) dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and 55 + 10 log (P) dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section. In addition, the attenuation factor shall not be less that 43 + 10 log (P) dB on all frequencies between 2490.5 MHzand 2496 MHz and 55 + 10 log (P) dB at or below 2490.5 MHz. Mobile Satellite Service licenseesoperating on frequencies below 2495 MHz may also submit a documented interference complaintagainst BRS licensees operating on channel BRS Channel 1 on the same terms and conditions as adjacent channel BRS or EBS licensees.

5. §27.53 (g)

For operations in the 698 -746 MHz band, the FCC limit is 43 + 10log10(P[Watts]) dB below the transmitter power P(Watts) in a 100 kHz bandwidth. However, in the 100 kilohertz bands immediately outside and adjacent to a licensee's frequency block, a resolution bandwidth of at least 30 kHz may be employed.



7.1.2 TEST SETUP



7.1.3 TEST PROCEDURES

- 1. The testing FCC KDB 971168 D01 v03r01 Section 6.0 and ANSI C63.26 2015 Section 5.7.
- 2. The EUT was connected to spectrum analyzer and system simulator via a power divider.
- 3. The band edges of low and high channels for the highest RF powers were measured. Set RBW >= 1% EBW in the 1MHz band immediately outside and adjacent to the band edge.
- 4. Set spectrum analyzer with RMS/AVG detector.
- 5. The RF fundamental frequency should be excluded against the limit line in the operating frquency band.
- 6. The limit line is derived from 43 + 10log(P)dB below the transmitter power P(Watts)
- = P(W)- [43 + 10log(P)] (dB)
- = [30 + 10log(P)] (dBm) [43 + 10log(P)] (dB)
- = -13dBm.

Band 7:

- = P(W) [55 + 10log(P)] (dB)
- = [30 + 10log(P)] (dBm) [55 + 10log(P)] (dB)
- = -25dBm.

	LTE							
LTE BW	1.4M	3M	5M	10M	15M	20M		
Span	12MHz	13MHz	15MHz	20MHz	25MHz	30MHz		
RBW	30kHz	30kHz	100kHz	100kHz	300kHz	300kHz		
VBW	100kHz	100kHz	300kHz	300kHz	1000kHz	1000kHz		
Detector	RMS	RMS	RMS	RMS	RMS	RMS		
Trace	Max	Max	Max	Max	Max	Max		
Sweep Count	Auto	Auto	Auto	Auto	Auto	Auto		

7.1.4 MEASUREMENT RESULT Note: Test chart See Appendix B



8. CONDUCTED SPURIOUS EMISSION

8.1 DESCRIPTION OF CONDUCTED SPURIOUS EMISSION MEASUREMENT

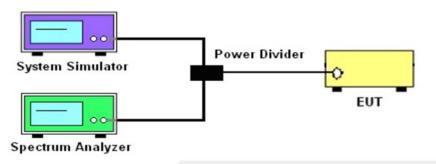
8.1.1 MEASUREMENT METHOD

The power of any emission outside of the authorized operating frequency ranges must be lower than the transmitter power (P) by a factor of at least 43 + 10 log (P) dB. For Band 7:

The power of any emission outside of the authorized operating frequency ranges must be lower than the transmitter power (P) by a factor of at least 55 + 10 log (P) dB.

It is measured by means of a calibrated spectrum analyzer and scanned from 30 MHz up to a frequency including its 10th harmonic.

8.1.2 TEST SETUP



8.1.3 TEST PROCEDURES

- 1. The testing FCC KDB 971168 D01 v03r01 Section 6.0 and ANSI C63.26 2015 Section 5.7.
- 2. The EUT was connected to spectrum analyzer and system simulator via a power divider.
- 3. The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement
- 4. Make the measurement with the spectrum analyzer's RBW = 1MHz, VBW = 3MHz, taking the record of maximum spurious emission.
- 5. The RF fundamental frequency should be excluded against the limit line in the operating frquency band.
- 6. The limit line is derived from 43 + 10log(P)dB below the transmitter power P(Watts)
- = P(W) [43 + 10log(P)] (dB) = [30 + 10log(P)] (dBm) [43 + 10log(P)] (dB)
- = -13dBm.

For Band 7: P(W)- [43 + 10log(P)] (dB) =-25dBm

	LTE							
LTE BW	1.4M	3M	5M	10M	15M	20M		
Span	Auto	Auto	Auto	Auto	Auto	Auto		
RBW	1000kHz	1000kHz	1000kHz	1000kHz	1000kHz	1000kHz		
VBW	3000kHz	3000kHz	3000kHz	3000kHz	3000kHz	3000kHz		
Detector	PK	PK	PK	PK	PK	PK		
Trace	Max	Max	Max	Max	Max	Max		

8.1.4 TEST RESULTS

Note: Test chart See Appendix C



9. RADIATED SPURIOUS EMISSION

9.1 DESCRIPTION OF RADIATED SPURIOUS EMISSION

9.1.1 MEASUREMENT METHOD

The radiated spurious emission was measured by substitution method according to ANSI C63.26 2015. The power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitter power (P) by a factor of at least 43 + 10 log (P) dB. For Band 7 The power of any emission outside of the authorized operating frequency ranges must attenuated below the transmitter power (P) by a factor of at least 55 + 10 log (P) dB. The spectrum is scanned from 30 MHz up to a frequency including its 10th harmonic.

9.1.2 TEST SETUP

The procedure of radiated spurious emissions is as follows:

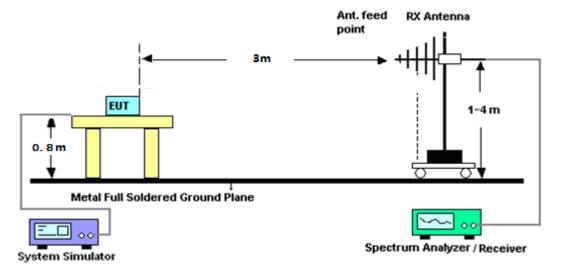
- a) Pre-calibration With pre-calibration method, the Radiated Spurious Emissions(RSE) is calculated as, RSE=Rx (dBuV) +CL (dB) +SA (dB) +Gain (dBi) -107 (dBuV to dBm) The SA is calibrated using following setup.
- b) EUT was placed on 1.5 m non-conductive stand at a 3 m test distance from the receive antenna. A receiving antenna was placed on the antenna mast 3 m from the test item for emission measurements. The height of receiving antenna is 0.8m. The test setup refers to figure below. Detected emissions were maximized at each frequency by rotating the test item and adjusting the receiving antenna polarization. The radiated emission measurements of all non-harmonic and harmonics of the transmit frequency through the 10th harmonic measured with peak detector and 1MHz bandwidth.

Radiated emissions measurements were made only at the upper, middle, and lower carrier frequencies It was decided that measurements at these three carrier frequencies would be sufficient to demonstrate compliance with emissions limits because it was seen that all the significant spurs occur well outside the band and no radiation was seen from a carrier in one block of any band into any of the other blocks.

The substitution method is used. Substitution values at each frequency are measured before and saved to the test software. A "reference path loss" is established and the ARpl is the attenuation of "reference path loss", and including the gain of receive antenna, the gain of the preamplifier, the cable loss and the air loss. The measurement results are obtained as described below:

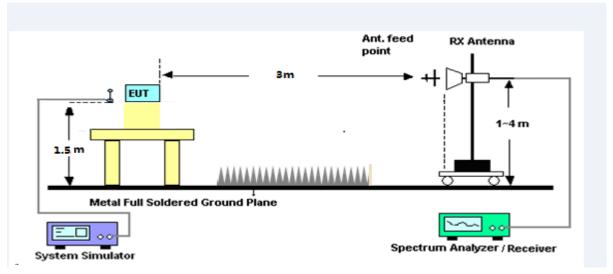
Power=PMea+ARpl

For radiated test from 30MHz to 1GHz





For radiated test from above 1GHz



9.1.3 TEST PROCEDURES

- 1. The testing FCC KDB 971168 D01 Section 7 and ANSI C63.26 2015 Section 5.5.
- 2. The EUT was placed on a rotatable wooden table with 1.5 meter above ground.
- 3. The EUT was set 3 meters from the receiving antenna, which was mounted on the antenna tower.
- 4. The table was rotated 360 degrees to determine the position of the highest spurious emission.
- 5. The height of the receiving antenna is varied between one meter and four meters to search the maximum spurious emission for both horizontal and vertical polarizations
- 6. Make the measurement with the spectrum analyzer's RBW = 1MHz, VBW = 3MHz, taking the record of maximum spurious emission.
- 7. A horn antenna was substituted in place of the EUT and was driven by a signal generator.
- 8. Tune the output power of signal generator to the same emission level with EUT maximum spurious emission.
- 9. Taking the record of output power at antenna port.
- 10. Repeat step 7 to step 8 for another polarization.
- 11. The RF fundamental frequency should be excluded against the limit line in the operating frequency band.

The limit line is derived from 43 + 10log(P)dB below the transmitter power P(Watts)

- = P(W)- [43 + 10log(P)] (dB)
- = [30 + 10log(P)] (dBm) [43 + 10log(P)] (dB)
- = -13dBm

For Band 7:

The limit line is derived from 55 + 10log(P)dB below the transmitter power P(Watts)

- = [30 + 10log(P)] (dBm) [55 + 10log(P)] (dB)
- = -25dBm

PMea=S.G Level+ Ant-Cable loss; Margin=PMea-Limit.



9.1.4 TEST RESULTS

Note: QPSK and 16QAM all has been tested, only shown the worst case in this report.

	LTE Band 4 / 1.4MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Lowest								
	I.TIVII IZ / QI OK / I		J113Ct 0/	PMea	Limit	Margin			
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity		
2420.06	22.64	12.90	10.56	-33.30		, , ,	Н		
3420.86	-33.64		12.56		-13.00	-20.30			
5132.10	-34.29	13.10	16.32	-37.51	-13.00	-24.51	Н		
6842.72	-32.62	12.33	21.13	-41.42	-13.00	-28.42	Н		
3420.86	-35.42	12.90	12.56	-35.08	-13.00	-22.08	V		
5132.10	-34.22	13.10	16.32	-37.44	-13.00	-24.44	V		
6842.72	-31.97	12.33	21.13	-40.77	-13.00	-27.77	V		
LTE Band 4 / '	1.4MHz / QPSK /	RB Size 1	Offset 0/	The Wor	rst Test Res	ults for M	iddle		
	0.01 (-10)	A 4(-ID:)	1	PMea	Limit	Margin	Dalasita		
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity		
3464.63	-34.12	12.90	12.56	-33.78	-13.00	-20.78	Н		
5196.56	-34.98	13.10	16.32	-38.20	-13.00	-25.20	Н		
6930.05	-33.51	12.33	21.13	-42.31	-13.00	-29.31	Н		
3464.63	-35.66	12.90	12.56	-35.32	-13.00	-22.32	V		
5196.56	-34.29	13.10	16.32	-37.51	-13.00	-24.51	V		
6930.05	-32.49	12.33	21.13	-41.29	-13.00	-28.29	V		
LTE Band 4 / 1	.4MHz / QPSK / F	RB Size 1 (Offset 0/	The Wor	st Test Resi	ults for Hi	ghest		
Fraguera (MIII)	C C L av (dDm)	Λ mt/dD:\	1 000	PMea	Limit	Margin	Dolovity		
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity		
3508.29	-34.03	12.90	12.56	-33.69	-13.00	-20.69	Η		
5262.60	-34.36	13.10	16.32	-37.58	-13.00	-24.58	Н		
7015.59	-33.09	12.33	21.13	-41.89	-13.00	-28.89	Н		
3508.29	-35.69	12.90	12.56	-35.35	-13.00	-22.35	V		
5262.60	-35.16	13.10	16.32	-38.38	-13.00	-25.38	V		
7015.59	-32.55	12.33	21.13	-41.35	-13.00	-28.35	V		



LTE Band 4 /	3MHz / QPSK / R	B Size 1 C	offset 0/	The Wors	t Test Resu	ilts for Lov	vest
Fraguera (MIII-)	C C L av (dDm)	^ mt/dD:\	Loop	PMea	Limit	Margin	Dolority
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity
3423.70	-34.81	12.90	12.56	-34.47	-13.00	-21.47	Н
5135.87	-34.19	13.10	16.32	-37.41	-13.00	-24.41	Н
6848.65	-32.71	12.33	21.13	-41.51	-13.00	-28.51	Н
3423.70	-34.58	12.90	12.56	-34.24	-13.00	-21.24	V
5135.87	-34.94	13.10	16.32	-38.16	-13.00	-25.16	V
6848.65	-33.20	12.33	21.13	-42.00	-13.00	-29.00	V
LTE Band 4 /	3MHz / QPSK / F	RB Size 1 C	Offset 0/	The Wors	st Test Resu	ults for Mic	ddle
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	PMea	Limit	Margin	Polarity
Frequency(MHZ)	S G.Lev (ubili)	Ant(dBi)	L055	(dBm)	(dBm)	(dBm)	
3464.80	-33.64	12.90	12.56	-33.30	-13.00	-20.30	Н
5196.66	-34.84	13.10	16.32	-38.06	-13.00	-25.06	Η
6929.72	-33.22	12.33	21.13	-42.02	-13.00	-29.02	Н
3464.80	-35.82	12.90	12.56	-35.48	-13.00	-22.48	V
5196.66	-34.06	13.10	16.32	-37.28	-13.00	-24.28	V
6929.72	-32.87	12.33	21.13	-41.67	-13.00	-28.67	V
LTE Band 4 /	3MHz / QPSK / R	B Size 1 O	ffset 0/	The Wors	t Test Resu	Its for Hig	hest
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	PMea	Limit	Margin	Polarity
Frequency(wiriz)	3 G.Lev (ubili)	Anti(ubi)	LUSS	(dBm)	(dBm)	(dBm)	Polarity
3505.97	-34.23	12.90	12.56	-33.89	-13.00	-20.89	Н
5261.71	-35.29	13.10	16.32	-38.51	-13.00	-25.51	Н
7012.41	-32.78	12.33	21.13	-41.58	-13.00	-28.58	Н
3505.97	-35.88	12.90	12.56	-35.54	-13.00	-22.54	V
5261.71	-34.03	13.10	16.32	-37.25	-13.00	-24.25	V
7012.41	-32.04	12.33	21.13	-40.84	-13.00	-27.84	V



LTE Band 4 /	5MHz / QPSK / R	B Size 1 C	offset 0/	The Wors	t Test Resu	ilts for Lov	vest
Fraguera (MIII-)	C C L av (dDm)	A mt/dD:\	Loop	PMea	Limit	Margin	Dolority
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity
3424.72	-34.22	12.90	12.56	-33.88	-13.00	-20.88	Н
5137.02	-35.22	13.10	16.32	-38.44	-13.00	-25.44	Н
6849.95	-32.31	12.33	21.13	-41.11	-13.00	-28.11	Н
3424.72	-34.79	12.90	12.56	-34.45	-13.00	-21.45	V
5137.02	-34.41	13.10	16.32	-37.63	-13.00	-24.63	V
6849.95	-31.99	12.33	21.13	-40.79	-13.00	-27.79	V
LTE Band 4 /	5MHz / QPSK / F	RB Size 1 C	Offset 0/	The Wors	st Test Resu	ults for Mic	ddle
Fraguerov/MUz)	C.C.L.ov. (dDm)	A :-4(-ID:)	Loop	PMea	Limit	Margin	Dolority
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity
3464.56	-33.91	12.90	12.56	-33.57	-13.00	-20.57	Н
5196.80	-34.67	13.10	16.32	-37.89	-13.00	-24.89	Η
6930.00	-32.97	12.33	21.13	-41.77	-13.00	-28.77	Η
3464.56	-35.05	12.90	12.56	-34.71	-13.00	-21.71	V
5196.80	-33.80	13.10	16.32	-37.02	-13.00	-24.02	V
6930.00	-31.86	12.33	21.13	-40.66	-13.00	-27.66	V
LTE Band 4 /	5MHz / QPSK / R	B Size 1 O	ffset 0/	The Wors	t Test Resu	Its for Hig	hest
Fraguenov/MUz)	S C Lov (dPm)	Ant(dDi)	Loca	PMea	Limit	Margin	Dolority
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity
3505.27	-34.03	12.90	12.56	-33.69	-13.00	-20.69	Н
5256.85	-35.22	13.10	16.32	-38.44	-13.00	-25.44	Н
7009.75	-33.10	12.33	21.13	-41.90	-13.00	-28.90	Н
3505.27	-35.78	12.90	12.56	-35.44	-13.00	-22.44	V
5256.85	-34.17	13.10	16.32	-37.39	-13.00	-24.39	V
7009.75	-33.00	12.33	21.13	-41.80	-13.00	-28.80	V



LTE Band 4 /	10MHz / QPSK / F	RB Size 1 (Offset 0/	The Wor	st Test Resi	ults for Lo	west
				PMea	Limit	Margin	
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity
3430.01	-34.16	12.90	12.56	-33.82	-13.00	-20.82	Н
5145.19	-35.21	13.10	16.32	-38.43	-13.00	-25.43	Н
6860.17	-33.26	12.33	21.13	-42.06	-13.00	-29.06	Н
3430.01	-34.90	12.90	12.56	-34.56	-13.00	-21.56	V
5145.19	-34.26	13.10	16.32	-37.48	-13.00	-24.48	V
6860.17	-31.98	12.33	21.13	-40.78	-13.00	-27.78	V
LTE Band 4 /	10MHz / QPSK / I	RB Size 1 (Offset 0/	The Wor	st Test Res	ults for Mi	ddle
Fraguera (MIII-)	C C L ov (dDm)	A 4(-ID:)	Loop	PMea	Limit	Margin	Dolority
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)		(dBm)	(dBm)	(dBm)	Polarity
3464.70	-33.60	12.90	12.56	-33.26	-13.00	-20.26	Н
5196.59	-34.60	13.10	16.32	-37.82	-13.00	-24.82	Н
6929.56	-33.01	12.33	21.13	-41.81	-13.00	-28.81	Н
3464.70	-36.02	12.90	12.56	-35.68	-13.00	-22.68	V
5196.59	-34.74	13.10	16.32	-37.96	-13.00	-24.96	V
6929.56	-32.30	12.33	21.13	-41.10	-13.00	-28.10	V
LTE Band 4 / '	10MHz / QPSK / F	RB Size 1 C	Offset 0/	The Wors	st Test Resu	ults for Hig	ghest
Fragues av (MIIII)	C C L ov (dDm)	Λ mt/dD:\	Loop	PMea	Limit	Margin	Dolority
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity
3500.28	-33.45	12.90	12.56	-33.11	-13.00	-20.11	Н
5250.18	-34.60	13.10	16.32	-37.82	-13.00	-24.82	Н
6999.90	-32.20	12.33	21.13	-41.00	-13.00	-28.00	Н
3500.28	-36.01	12.90	12.56	-35.67	-13.00	-22.67	V
5250.18	-34.81	13.10	16.32	-38.03	-13.00	-25.03	V
6999.90	-32.94	12.33	21.13	-41.74	-13.00	-28.74	V



ITE Band 4 /	LTE Band 4 / 15MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Lowest								
				PMea	Limit	Margin			
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity		
3434.63	-34.19	12.90	12.56	-33.85	-13.00	-20.85	Н		
5152.48	-34.72	13.10	16.32	-37.94	-13.00	-24.94	Н		
6870.41	-32.27	12.33	21.13	-41.07	-13.00	-28.07	Н		
3434.63	-35.78	12.90	12.56	-35.44	-13.00	-22.44	V		
5152.48	-34.42	13.10	16.32	-37.64	-13.00	-24.64	V		
6870.41	-32.66	12.33	21.13	-41.46	-13.00	-28.46	V		
LTE Band 4 /	15MHz / QPSK / I	RB Size 1 (Offset 0/	The Wor	st Test Res	ults for Mi	ddle		
	C C L av. (dDras)	Λ :=4/-dD:\	1	PMea	Limit	Margin	Delevite		
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity		
3464.62	-34.55	12.90	12.56	-34.21	-13.00	-21.21	Н		
5196.54	-34.90	13.10	16.32	-38.12	-13.00	-25.12	Н		
6930.11	-32.42	12.33	21.13	-41.22	-13.00	-28.22	Н		
3464.62	-35.71	12.90	12.56	-35.37	-13.00	-22.37	V		
5196.54	-34.37	13.10	16.32	-37.59	-13.00	-24.59	V		
6930.11	-32.19	12.33	21.13	-40.99	-13.00	-27.99	V		
LTE Band 4 / '	15MHz / QPSK / F	RB Size 1 C	Offset 0/	The Wors	st Test Resu	ılts for Hiç	hest		
Fragueray/MII=	C.C.L.ov. (dDms)	Λ mt/dD:\	Loop	PMea	Limit	Margin	Dolority		
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity		
3495.21	-33.74	12.90	12.56	-33.40	-13.00	-20.40	Н		
5242.21	-35.28	13.10	16.32	-38.50	-13.00	-25.50	Н		
6990.27	-32.65	12.33	21.13	-41.45	-13.00	-28.45	Н		
3495.21	-35.71	12.90	12.56	-35.37	-13.00	-22.37	V		
5242.21	-34.66	13.10	16.32	-37.88	-13.00	-24.88	V		
6990.27	-32.63	12.33	21.13	-41.43	-13.00	-28.43	V		



LTE Band 4 / 2	20MHz / QPSK / F	RB Size 1 (Offset 0/	The Wor	st Test Resi	ults for Lo	west
				PMea	Limit	Margin	
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity
3439.90	-33.96	12.90	12.56	-33.62	-13.00	-20.62	Н
5160.03	-34.10	13.10	16.32	-37.32	-13.00	-24.32	Н
6880.48	-32.66	12.33	21.13	-41.46	-13.00	-28.46	Н
3439.90	-35.08	12.90	12.56	-34.74	-13.00	-21.74	V
5160.03	-35.16	13.10	16.32	-38.38	-13.00	-25.38	V
6880.48	-33.10	12.33	21.13	-41.90	-13.00	-28.90	V
LTE Band 4 /	20MHz / QPSK / I	RB Size 1 (Offset 0/	The Wor	st Test Res	ults for Mi	ddle
	C C L av. (dDras)	۸ ۱/ ما D: ۱	1	PMea	Limit	Margin	Polarity
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	
3464.62	-34.86	12.90	12.56	-34.52	-13.00	-21.52	Н
5196.66	-34.80	13.10	16.32	-38.02	-13.00	-25.02	Н
6929.51	-32.48	12.33	21.13	-41.28	-13.00	-28.28	Н
3464.62	-34.93	12.90	12.56	-34.59	-13.00	-21.59	V
5196.66	-34.60	13.10	16.32	-37.82	-13.00	-24.82	V
6929.51	-32.52	12.33	21.13	-41.32	-13.00	-28.32	V
LTE Band 4 / 2	20MHz / QPSK / F	RB Size 1 C	Offset 0/	The Wors	st Test Resu	ults for Hig	ghest
Fraguera (MIII)	C C L av (dDm)	Λ mt/dD:\	1 000	PMea	Limit	Margin	Dolority
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity
3490.29	-33.54	12.90	12.56	-33.20	-13.00	-20.20	Н
5234.97	-35.12	13.10	16.32	-38.34	-13.00	-25.34	Н
6979.70	-33.46	12.33	21.13	-42.26	-13.00	-29.26	Н
3490.29	-34.58	12.90	12.56	-34.24	-13.00	-21.24	V
5234.97	-34.70	13.10	16.32	-37.92	-13.00	-24.92	V
6979.70	-32.29	12.33	21.13	-41.09	-13.00	-28.09	V



10. FREQUENCY STABILITY

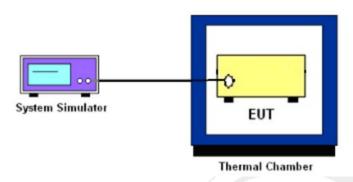
10.1 DESCRIPTION OF FREQUENCY STABILITY MEASUREMENT

10.1.1 MEASUREMENT METHOD

The frequency stability shall be measured by variation of ambient temperature and variation of primary supply voltage to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within $\pm 0.00025\%$ (± 2.5 ppm) of the center frequency.

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10.1.2 TEST SETUP



10.1.3 TEST PROCEDURES FOR TEMPERATURE VARIATION

- 1. The EUT was set up in the thermal chamber and connected with the system simulator.
- 2. With power OFF, the temperature was decreased to -30°C and the EUT was stabilized before testing. Power was applied and the maximum change in frequency was recorded within one minute.
- 3. With power OFF, the temperature was raised in 10°C step up to 50°C. The EUT was stabilized at each step for at least half an hour. Power was applied and the maximum frequency change was recorded within one minute.

10.1.4 TEST PROCEDURES FOR VOLTAGE VARIATION

- 1. The testing follows FCC KDB 971168 D01v01r03 Section 9.
- 2. The EUT was placed in a temperature chamber at 25±5° C and connected with the system simlator.
- 3. The power supply voltage to the EUT was varied from 85% to 115% of the nominal value measured at the input to the EUT.
- 4. The variation in frequency was measured for the worst case.



10.1.5 TEST RESULTS

	LTE Band 4 (Q	PSK) / 1733	MHz / BW10I	M	
Temperature (°C)	Voltage	Freq. Dev.	Freq. Dev.	Limit	Result
	(Volt)	(Hz)	(ppm)		
50		20.27	0.012		
40		24.17	0.014		
30		31.82	0.018	25000	PASS
20		11.73	0.007		
10	Normal Voltage	24.93	0.014		
0		12.98	0.007		
-10		20.75	0.012	2.5ppm	FASS
-20		19.64	0.011		
-30		35.09	0.020		
20	Maximum Voltage	23.66	0.014		
20	BEP	18.84	0.011		

LTE Band 4 (QPSK) / 1733MHz / BW20M								
Temperature (°C)	Voltage	Freq. Dev.	Freq. Dev.	Limit	Result			
. , ,	(Volt)	(Hz)	(ppm)					
50		16.32	0.009					
40		21.83	0.013					
30		21.06	0.012					
20		18.05	0.010					
10	Normal Voltage	28.83	0.017	2 5000	PASS			
0		14.89	0.009					
-10		24.12	0.014	2.5ppm	PASS			
-20		34.12	0.020					
-30		13.70	0.008					
20	Maximum Voltage	16.38	0.009					
20	BEP	20.51	0.012					



APPENDIX-PHOTOS OF TEST SETUP

Note: See test photos in setup photo document for the actual connections between Product and support equipment.

* * * * END OF THE REPORT * * * *

